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density functional theory calculations

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Optimal atomic structure of amorphous silicon obtained from

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Abstract

PAPER

Atomic structure of amorphous silicon consistent with several reported experimental measurements has been obtained from annealing simulations using electron density functional theory calculations and a systematic removal of weakly bound atoms. The excess energy and density with respect to the crystal are well reproduced in addition to radial distribution function, angular distribution functions, and vibrational density of states. No atom in the optimal configuration is locally in a crystalline environment as deduced by ring analysis and common neighbor analysis, but coordination defects are present at a level of 1%–2%. The simulated samples provide structural models of this archetypal disordered covalent material without preconceived notion of the atomic ordering or fitting to experimental data.

Amorphous silicon (*a*-Si) is the archetypal disordered covalently bonded material. It is also widely used for industrial purposes, with numerous applications in electronics and photovoltaics. Both aspects have triggered an intense research activity during the last few decades. *a*-Si can be obtained using several preparation techniques, including ion implantation, laser melting followed by fast quenching, various growth methods, and indentation [1–6]. The characteristics of the *a*-Si samples depend on the preparation method [7]. For example, vapor deposition often gives samples that include voids. Also, *a*-Si obtained by ion implantation tends to include a significant amount of coordination defects. But, annealing of the various types of samples seems to bring them closer to some common, ideal *a*-Si structure. The nature of this state is, however, a matter of long standing controversy. In addition to gaining an understanding of the basic characteristics of covalently bonded disordered networks, good structural models are an important prerequisite for theoretical investigations of the electronic and mechanical properties of such materials [8].

Several different procedures have been proposed to generate realistic atomic scale models of *a*-Si. One approach is to generate a continuous random network (CRN) which can be built using various algorithms to give a structure with only 4-fold coordinated atoms, i.e. containing no coordination defects [9–11]. Another structural model involves nanoscopic crystal grains embedded in a disordered matrix. Arguments in favor of the latter have recently been presented in connection with an analysis of ion implantation samples [5, 12]. Finally, constraints derived from experimental data have been used to guide the construction of *a*-Si models [13–15].

Most of the proposed models have been able to reproduce well some of the measured structural features such as the radial distribution function (RDF) and bond angle distributions. The RDF, however, cannot discriminate between the various topological networks [12], and detailed information about the angular distributions is hard to obtain from experiments. To progress further in the search for an optimal *a*-Si model, Drabold recently proposed to focus on the excess energy ΔE stored in the amorphous network relative to the crystal, *c*-Si, a quantity that can be extracted from calorimetry experiments [16]. This has so far not been considered as a critical property in simulation studies. Samples prepared by ion implantation have given excess enthalpy of 0.15 eV atom⁻¹ [1, 17], and more recently vapor deposition has been found to give a lower value,

0.07 eV atom⁻¹ [6]. Available *a*-Si models often correspond to higher excess energy [7, 14, 18–21], suggesting that they might not be representative of the experimental *a*-Si structure. Another important property is the density, ρ , which has been found experimentally to be 1%–2% lower than the density of *c*-Si in several measurements [12, 22, 23]. As shown below, the density is useful for assessing the quality of a structural model, and the convergence of annealing simulations.

The generation of *a*-Si structures without preconceived notion of the atomic ordering or input from experimental observations has proven to be challenging. One possibility is to simulate a rapid quench of the liquid. But, due to computational limitations, empirical potential functions are often used to describe atomic interactions. Their limited accuracy has resulted in a high density of structural defects [24, 25], and an overall poor agreement with available experimental information on *a*-Si. In order to improve on this approach, we have carried out annealing simulations with a density functional theory (DFT) description of the electronic degrees of freedom so the final structure is dictated by atomic interactions determined from first principles calculations. In order to speed up the annealing process and optimize the density as well as the energy, a systematic procedure for removing weakly bound atoms was developed. This turns out to be an efficient procedure for generating an *a*-Si structure with calculated properties in excellent agreement with reported experimental measurements of ion implantation samples, including RDF, angular distributions and vibrational density of states, as well as the excess energy and relative density with respect to *c*-Si.

The starting configuration was generated by rapid cooling of liquid Si represented by a 216 atom system subject to periodic boundary conditions with volume chosen to correspond to that of the crystalline phase of silicon. The temperature was reduced at a rate of 2×10^{12} K s⁻¹, typical of laser experiments [24], down to a temperature of 10 K. The empirical potential function of Tersoff [26] was used in this initial phase of the simulation to reduce the computational effort. Following the cooling, the energy was minimized with respect to an isotropic scaling of the volume of the simulation box and with respect to atomic coordinates before any DFT calculations were done. The structural characteristics of the configuration obtained in this way is in some ways already in relatively good agreement with experiments although there are also clear discrepancies. The RDF is close to the experimental one, but the 1st peak is shifted 2% compared with experiments towards larger pair distances [23]. Also, while the angular distribution function has a maximum at 108.1°, in agreement with experimental values ranging from 9.0° to 11° [2, 6, 23].

The sample was then annealed by carrying out simulations where the energy and atomic forces were evaluated with DFT. The PBE generalized gradient approximation to the exchange and correlation functional [27], was used with valence electrons represented in a plane wave basis extended to 18 Ry and only Γ -point in the k-point sampling while inner electrons were represented with projector augmented-wave [28]. This gives a lattice constant of 5.468 Å for the Si crystal. The VASP software was used for the calculations [29]. A classical dynamics simulation was carried out at a temperature of 600 K followed by short, 1 ps dynamics at 300 K and finally conjugate gradient energy minimization with respect to atomic coordinates at fixed volume. Figure 1 shows how the excess energy of the sample depends on the length of the time interval simulated at 600 K. While the first 10 ps had a large effect, an extension to 20 ps gave only insignificant further reduction in the energy.

The density at this point is too high compared with the density of the Si crystal at the DFT/PBE level of theory since the volume had been fixed at the volume of the crystal described by the empirical potential [26]. A minimization of the DFT/PBE energy with respect to the volume box was then carried out by an isotropic scaling of the atom coordinates, followed by minimization of the energy with respect to atom coordinates. The excess energy of this configuration, labeled *e* in figure 1, is 0.167 eV atom⁻¹. This is significantly lower than previously published theoretical values [10, 14, 18, 20, 30], but higher than the experimental estimates [1, 6, 17]. The density, is also too high, close to the DFT/PBE crystal density, and the position of the 1st peak in the RDF is almost the same as in *c*-Si. The dispersion of the 1st RDF peak is 0.045 Å. This is similar to experimental values [23]. The angular distribution has a peak at 108.4° with a dispersion of 10.5°. This indicates that the DFT/PBE description of the atomic forces is significantly better than the empirical potential function [26] used to generate the initial configuration. In fact, we have found that much longer annealing simulations with the empirical potential function were not able to lower the excess energy to the extent that has been done at this point in the DFT/PBE calculations. Using a cutoff bond distance of 2.8 Å, configuration *e* is found to include 7 fivefold and 1 threefold coordinated atoms, corresponding to 4% coordination defects, and the average coordination number is 4.03.

In order to optimize the atomic structure and density further, an annealing scheme was developed that is more efficient than direct dynamical simulations. This is important since the time interval that can be simulated with reasonable computational effort is very limited. Two different calculations were carried out, one starting from configuration *e* which has high density, and the other from a low density configuration. In the end similar density was obtained for the optimal, low energy configurations, confirming the efficiency of the approach. The presence of coordination defects suggests that further optimization of the atomic structure and density could be



Figure 1. Energy and density of the simulated *a*-Si samples relative to that of *c*-Si, evaluated from electronic density functional theory calculations. *a*: input configuration obtained by rapid quenching of a liquid using an empirical potential (vertical dashed line). *b*, *c*, *d*: after simulating dynamics at 600 K using DFT (for 1, 10 and 20 ps, resp.) followed by energy minimization with respect to atom coordinates at fixed volume. Two PDA annealing calculations are then carried out. I (black): energy was minimized with respect to the volume of the box (black dashed line) prior the PDA treatment, which is an iterative removal of atoms with the smallest binding energy and volume optimization. After the first iteration configuration *f* is obtained, *g* results after removing two atoms, etc, and the PDA annealing leads to the optimal, low energy configuration labeled *i* containing 212 atoms. II (red): the volume is increased to reduce the density to ca 2% below that of *c*-Si and dynamics simulated at 900, 600 and 300 K for 10 ps in each case, followed by minimization of the energy with respect to both atomic coordinates and volume (red dashed line), leading to a lower density sample, *x*. From the following PDA calculations, the optimal low energy configuration labeled *y* with 215 atoms results. The optimal configurations obtained from the PDA annealing I and II have nearly the same density, 99% of the *c*-Si density.

achieved by removing atoms with low binding energy. Previous investigations of point defects in *a*-Si models have shown that in some cases the vacancy formation energy is negative, i.e. the energy of the system could be lowered by removing an atom [31]. An analysis of the structure of bond defects in our samples revealed that fivefold coordinated atoms tend to cluster together, as had been noted in some previous investigations [24]. We performed a systematic search for such 'high energy atoms' using a procedure which in the following will be referred to as point defect annihilation (PDA): (1) An atom is removed followed by a minimization of the energy with respect to the coordinates of the rest of the atoms. This is repeated for all the atoms in the system and the final configuration with the lowest energy selected for further processing. (2) An annealing of the selected configuration is then carried out for 1 ps at 600 K and for 1 ps at 300 K followed by minimization of the energy with respect to coordinates and rescaling of the volume. Steps (1) and (2) were repeated until the PDA procedure led to an increase in the final energy. We note that due to the annealing and relaxation with respect to the volume, the PDA procedure can lead to an increase in the density despite the fact that atoms are removed from the system.

The results of the PDA calculations starting with configuration e are shown in figure 1. The excess energy dropped from 0.167 to 0.156 eV atom⁻¹ after four iterations (removing 4 atoms, configuration *i* in figure 1).

Since the PDA procedure described above started from a configuration with high density, close to that of the crystal, it is possible that the configuration obtained is biased towards high density. Therefore, a different initial configuration for the PDA procedure was generated by increasing the volume of the simulation box by ca 2% followed by annealing at 900, 600 and 300 K for 10 ps at each temperature setting, and then energy minimization with respect to the atom coordinates and an isotropic scaling of the simulation box (configuration *x* in figure 1). The density of this configuration is 1.8% lower than the density of the crystal and the excess energy is 0.160 eV atom⁻¹. When the PDA procedure is applied to this configuration, the density increases to a similar optimal value (sample *y* in figure 1) as the optimal configuration obtained in the previous PDA calculation, ca 99% of the crystal density. This optimal density has, therefore, been obtained with the PDA procedure starting both from values above and from below.

This second PDA annealing simulation generates, however, a configuration with even lower excess energy than obtained before, 0.149 eV atom⁻¹ after removal of just one atom. This value of the excess energy is much lower than what has been reported previously from model calculations and is in good agreement with experimental estimates for samples created by ion implantation [1, 17]. We note that the total simulated annealing time used to generate this optimal configuration is quite short, 53 ps.

At the optimum for the PDA annealing, the energy of the system is not lowered further by removing an atom, i.e. no atom gives rise to a negative vacancy formation energy as shown in figure 2. As expected, the PDA procedure indeed results in a reduction of the number of coordination defects. The configuration with the





lowest energy per atom (sample *y* in figure 1) only includes one threefold and three fivefold coordinated atoms. Sample *i* in figure 1 which has larger excess energy actually contains fewer coordination defects, only one fivefold and one threefold coordinated atom. The excess energy is therefore not necessarily related to the number of coordination defects, in agreement with an earlier study by Bernstein *et al* [20]. This indicates that it can be energetically advantageous to introduce coordination defects in *a*-Si. The abundance of coordination defects in these samples corresponds to 1%–2% of the atoms, close to estimates for samples prepared by ion implantation [23].

The optimal density obtained in these simulations, 99% of the crystal density, is within the range of values determined experimentally for *a*-Si samples prepared by ion implantation [6, 22, 23]. Some measurements have given a density as low as 98% but, as stated by the authors, it is likely that those samples include a small concentration of vacancies even after annealing [23]. This is consistent with the low value of the coordination number determined for those samples, 3.88. In all our optimized samples, the coordination number is higher, 3.99–4.02. Another explanation could be that the experiments are carried out at non-zero temperature, and therefore contain an equilibrium concentration of point defects such as vacancies. While thermal defect concentration is usually small in *c*-Si due to the high formation energy of about 3.6 eV, vacancies in *a*-Si can be created at a much lower cost. In fact, the computed distribution of the vacancy formation energy in our optimal *a*-Si sample, shown in figure 2, includes a value as low as 0.13 eV.

Other structural characteristics of the lowest energy configuration are also in close agreement with available experimental data, as shown in figure 3. In order to compare with room temperature measurements, the RDF was calculated as an average over a large number of configurations generated by DFT/PBE classical dynamics after heating the lowest energy configuration, sample *y*, to 300 K. The agreement is excellent, as shown in figure 3. The 1st peak position in the RDF is similar to the 1st neighbor distance in *c*-Si as has been found in experiments [23]. The bond angle distribution is also in close agreement with experiment as shown in figure 3. The maximum occurs at $(108.2 \pm 0.2)^\circ$, in excellent agreement with available measurements of $(108.5 \pm 0.2)^\circ$ [2], and $(107.8 \pm 0.97)^\circ$ [23]. The dispersion in the bond angle distribution is also in excellent agreement with experiment agreement with experimental estimates [2, 6, 23].

It has been postulated that medium-range order in *a*-Si is due to the presence of crystalline regions [12], and models of *a*-Si have been proposed that include crystalline grains [14]. These models can reproduce the variance of the measured diffraction signal in fluctuation electron microscopy experiments, but are characterized by large excess energy compared to *c*-Si, larger than the experimental estimates. One way to characterize medium-range order is the dihedral angle distribution. The samples generated here have distributions with well defined peaks at 60° and 180° , a clear indication of medium-range order, see figure 3.

A more detailed analysis of the medium range order can be carried out using ring analysis, i.e. count the number of atoms in shortest rings formed by Si–Si bonds [32]. The results of such analysis is shown in table 1. In



Figure 3. Comparison of various structural properties of the lowest energy configuration, sample *y*, with experimental measurements. Upper panel: radial distribution function calculated (solid line) and measured [23], (gray shaded area). The inset shows the bond angle distribution (solid line) along with experimentally estimated dispersion (gray vertical bars) [2, 6, 23]. The inset also shows the dihedral angle distribution (dashed line) with the most frequent values in *c*-Si marked by dotted lines, revealing medium range order despite the fact that no atoms are locally in a crystalline environment. Lower panel: vibrational density of states calculated (solid line) and measured [37] (gray shaded area).

Table 1. Rings and common neighbor analysis of the local structure in the optimal configuration, *y*, and in the CRN configuration.

	Sample y	CRN
Rings/atom		
3	0.005	0.000
4	0.042	0.025
5	0.391	0.495
6	0.772	0.630
7	0.023	0.035
CNA pairs %		
(211)	5.7	5.7
(311)	16.4	24.8
(322)	9.1	9.5
(411)	20.8	16.0
(421)	13.9	12.7
(422)	11.5	10.3
(433)	19.4	19.3
(532)	16.8	14.3
(544)	10.4	7.7
(555)	3.7	2.4

c-Si, each atom forms 6 rings with 6 atoms. Such analysis has been used to identify atoms locally in crystalline environment in models of a-Si [19]. Our optimal configuration contains no atom with the ring characteristics of c-Si.

Another structural analysis method that has been used in studies of amorphous packings of atoms is based on counting the number of common neighbors and analyzing the number and arrangement of bonds between common neighbors [33–35]. This is referred to as common neighbor analysis (CNA). The method has recently

been extended to systems where the atoms ideally have fourfold coordination [36]. There, the analysis is carried out for second nearest neighbors rather than first nearest neighbors. An atom in *c*-Si forms 12 pairs of the (421) type with its second neighbors, while an atom in a hexagonal diamond lattices forms 6 pairs of (421) type and 6 pairs of (422) type. The results of CNA for our optimal configuration are shown in table 1. None of the atoms in our optimal configuration forms the set of pairs characteristic of crystalline ordering. Analogous to the results of the ring analysis, no atom is found to be in a local environment characteristic of the crystal. This shows that medium-range order could be present in well relaxed *a*-Si models without the presence of crystal grains.

The vibrational density of states, computed within the harmonic approximation for our optimal configuration is also shown in figure 3 along with experimental data obtained by neutron scattering of a sputter deposited sample of *a*-Si [37]. The force constant matrix was evaluated from the DFT/PBE calculations. The agreement between the calculation and the measurement is excellent, further supporting the high quality of the atomic configuration.

Finally, we have made detailed comparison of our optimal configuration with a high-quality CRN sample [10] containing 200 atoms. The generation of such samples is not based on the energy but is subject to the constraint that all atoms are fourfold coordinated, i.e. no coordination defects. After minimization of the DFT/ PBE energy with respect to atom coordinates and volume starting with the coordinates of the CRN, the excess energy with respect to the crystal is found to be practically the same as that of our lowest energy sample, 0.149 eV atom⁻¹. This is quite low, comparable to our optimal configuration. However, the density of the relaxed CRN configuration is significantly lower, only 96.7% of the crystal density, well below experimental estimates. The CRN configuration is also quite different from our optimal configuration in many respects. It contains no coordination defects even after relaxation with DFT/PBE while our lowest energy sample has 2% coordination defects. This again raises the question whether some small density of coordination defects is in fact an essential characteristic of a-Si. The results of ring and CNA of the CRN configuration is given in table 1. No atom is classified as being in a crystalline environment by either analysis method, analogous to our optimal configuration. But, there is a clear difference in the abundance of rings, the CRN having fewer sixfold rings and more five- and sevenfold rings. The CNA results show a larger abundance of pairs corresponding to 3 common second neighbors while the abundance of pairs corresponding to 4 and 5 is lower. The abundance of (555) and (544) pairs, which are elements of an (distorted) icosahedron, is only ca 2/3 of that in our optimal configuration.

The electronic density of states calculated with DFT/PBE for the lowest energy configuration gives a band gap that is a factor of 1.48 larger than that calculated for the crystal at the same level of theory. While the calculated band gaps are known to be too small in DFT/PBE, this ratio is in excellent agreement with the ratio of experimentally determined band gaps, 1.55 (see [38]). Two defect peaks are found in the gap, 0.09 and 0.15 eV above the valence band edge, presumably corresponding to the coordination defects. The DFT/PBE calculations of the relaxed CRN sample, however, showed no defect states within the electronic band gap consistent with the fact that no coordination defects are present. Further study of the electronic properties of the various *a*-Si samples will be reported elsewhere.

In summary, we have used an annealing procedure based on electron DFT to generate an atomic configuration for amorphous silicon that is in excellent agreement with the various experimental measurements, including excess energy with respect to the crystal, density, coordination defect density, RDF, angular distribution functions and vibrational density of states. Our approach is in part based on a systematic procedure for removing weakly bound atoms. The optimal configuration obtained has no atoms in a local environment characteristic of crystalline order as deduced from ring analysis and CNA.

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References

- [1] Roorda S, Doorn S, Sinke W, Scholte P and van Loenen E 1989 Phys. Rev. Lett. 62 1880
- [2] Fortner J and Lannin J 1989 Phys. Rev. B 39 5527
- [3] van den Hoven G, Liang Z N and Niesen L 1992 Phys. Rev. Lett. 68 3714
- [4] Laaziri K, Kycia S, Roorda S, Chicoine M, Robertson JL, Wang J and Moss SC 1999 Phys. Rev. Lett. 82 3460
- [5] Haberl B, Liu A C Y, Bradby J E, Ruffell S, Williams J S and Munroe P 2009 Phys. Rev. B 79 155209
- [6] Kail F, Farjas J, Roura P, Secouard C, Nos O, Bertomeu J and Cabarrocas P R I 2011 Phys. Status Solidi RRL 5 361

^[7] Holmström E, Haberl B, Pakarinen O, Nordlund K, Djurabekova F, Arenal R, Williams J, Bradby J, Petersen T and Liu A 2016 J. Non-Cryst. Solids 438 26

- [8] Fusco C, Albaret T and Tanguy A 2010 Phys. Rev. E 82 066116
- [9] Wooten F, Winer K and Weaire D 1985 Phys. Rev. Lett. 54 1392
- [10] Barkema G and Mousseau N 2000 Phys. Rev. B 62 4985 and references therein
- [11] Wright A and Thorpe M 2013 Phys. Status Solidi b 250 931
- [12] Treacy M M J and Borisenko K B 2012 Science 335 950
- [13] Cliffe M J, Dove M T, Drabold D A and Goodwin A L 2010 Phys. Rev. Lett. 104 125501
- [14] Borisenko K, Haberl B, Liu A, Chen Y, Li G, Williams J, Baradby J, Cockayne D and Tracy M 2012 Acta Mater. 60 359
- [15] Hejna M, Steinhardt P J and Torquato S 2013 Phys. Rev. B 87 245204
- [16] Drabold D A 2011 Phys. Status Solidi RRL 5 359
- [17] Roorda S, Sinke W, Poate J, Jacobson D, Dierker S, Dennis B, Eaglesham D, Spaepen F and Fuoss P 1991 Phys. Rev. B 44 1880
- [18] Durandurdu M, Drabold D and Mousseau N 2000 Phys. Rev. B 62 15307
- [19] Voyles P M, Zotov N, Nakhmanson S M, Drabold D A, Gibson J M, Treacy M M J and Keblinski P 2001 J. Appl. Phys. 90 4437
- [20] Bernstein N, Feldman J and Fornari M 2006 Phys. Rev. B 74 205202
- [21] Shodja H M, Tabatabaei M and Esfarjani K 2014 Phil. Mag. 94 2913
- [22] Custer J S, Thompson M O, Jacobson D C, Poate J M, Roorda S, Sinke W C and Spaepen F 1994 Appl. Phys. Lett. 64 437
- [23] Laaziri K, Kycia S, Roorda S, Chicoine M, Robertson JL, Wang J and Moss S C 1999 Phys. Rev. B 60 13520
- [24] Luedtke W and Landman U 1989 Phys. Rev. B 40 1164
- [25] Ishimaru M 2002 J. Appl. Phys. 91 686
- [26] Tersoff J 1988 Phys. Rev. B 38 9902
- [27] Perdew J P, Burke K and Ernzerhof M 1996 Phys. Rev. Lett. 77 3865
- [28] Blöchl P E 1994 *Phys. Rev.* B **50** 17953
- [29] Kresse G and Furthmüller J 1996 Comput. Mater. Sci. 6 15
- [30] Ŝtich I, Car R and Parrinello M 1991 Phys. Rev. B 44 11092
- [31] Miranda C, Antonelli A, da Silva A and Fazzio A 2004 J. Non-Cryst. Solids 338–340 400
- [32] Le Roux S and Jund P 2010 Comput. Mater. Sci. 49 70
- [33] Jónsson H and Andersen H C 1988 Phys. Rev. Lett. 60 2295
- [34] Clarke A and Jónsson H 1993 Phys. Rev. E 47 3975
- [35] Shumway S, Clarke A S and Jónsson H 1995 J. Chem. Phys. 102 1796
- [36] Maras E, Trushin O, Stukowski A, Ala-Nissila T and Jónsson H 2016 Comput. Phys. Commun. 205 13
- [37] Kamitakahara W A, Soukoulis C M, Shanks H R, Buchenau U and Grest G S 1987 Phys. Rev. B 36 6539
- [38] Choudhary D and Clancy P 2005 J. Chem. Phys. 122 174509